

## P-Channel Enhancement Mode MOSFET

### ● Features

VDS	VGS	RDSon TYP	ID
-20	8V	60mR@4V5	3A
		75mR@2V5	

### ● General Description

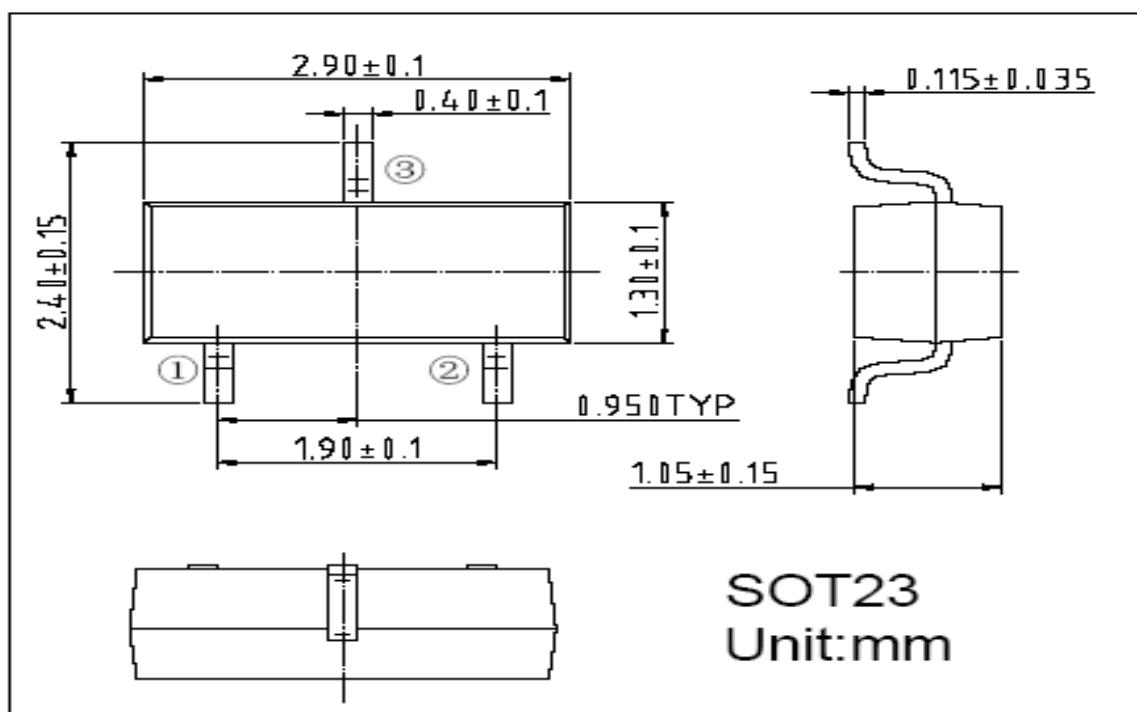
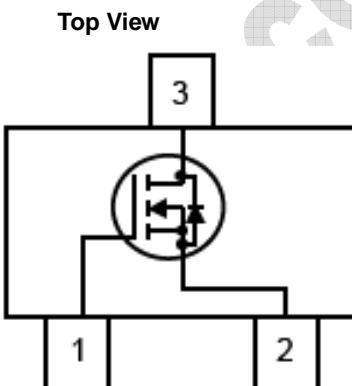
This device is produced with high cell density DMOS trench technology, which is especially used to minimize on-state resistance. This device particularly suits low voltage applications such as portable equipment, power management and other battery powered circuits, and low in-line power dissipation are needed in a very small outline surface mount package. Excellent thermal and electrical capabilities.

### ● Package Information

### ● Applications

- >Load Switch
- >Portable Devices
- >DCDC conversion

### ● Pin configuration



● **Absolute Maximum Ratings @ TA = 25°C unless otherwise noted**

Parameter		Symbol	Ratings	Unit
Drain-Source Voltage		V <sub>DSS</sub>	-20	V
Gate-Source Voltage		V <sub>GSS</sub>	±8	V
Drain Current (Continuous)		I <sub>D</sub>	-3	A
Drain Current (Pulse)		I <sub>DM</sub>	-20	A
Power Dissipation	25°C	P <sub>D25</sub>	550	mW
	70°C	P <sub>D70</sub>	350	
Operating Temperature/ Storage Temperature		T <sub>J/T STG</sub>	-55~150	°C

● **Electrical Characteristics @ TA = 25°C unless otherwise noted**

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
<b>OFF CHARACTERISTICS</b>						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA	-20	--	--	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -20 V, V <sub>GS</sub> = 0V	--	--	-1	μA
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ±8 V, V <sub>DS</sub> = 0V	--	--	±100	nA
<b>ON CHARACTERISTICS<sup>(2)</sup></b>						
Gate Threshold Voltage	V <sub>G(S)TH</sub>	V <sub>DS</sub> = V <sub>G(S)</sub> , I <sub>D</sub> = 50μA	-0.45	-0.75	-1.5	V
Drain-Source On-Resistance	R <sub>D(S)ON</sub>	V <sub>G(S)</sub> = 4.5 V, I <sub>D</sub> = 3.6 A	--	60	130	mR
		V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -2A	--	75	200	mR
Forward Transconductance	G <sub>F</sub>	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 3.6 A	--	6.5	--	S
<b>DYNAMIC CHARACTERISTICS</b>						
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> = -6V, V <sub>GS</sub> = 0V f = 1 MHz	--	415	--	pF
Output Capacitance	C <sub>OSS</sub>		--	223	--	pF
Reverse Transfer Capacitance	C <sub>rss</sub>		--	87	--	pF
<b>SWITCHING CHARACTERISTICS</b>						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = -6V, R <sub>L</sub> = 6R, I <sub>D</sub> = -1.0A, V <sub>GEN</sub> = -4.5V, R <sub>G</sub> = 6R	--	13	25	nS
Turn-off Delay Time	t <sub>d(off)</sub>		--	42	70	nS
<b>DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS</b>						
Drain-Source Diode Forward Voltage	V <sub>SD</sub>	I <sub>s</sub> = -1.6A, V <sub>GS</sub> = 0V	-0.5	--	-1.2	V

Notes:

1. Pulse width limited by maximum junction temperature.
2. Pulse test: PW≤300us, duty cycle≤2%.
3. For design AID only, not subject to production testing.
4. Switching time is essentially independent of operating temperature.

● Typical Performance Characteristics

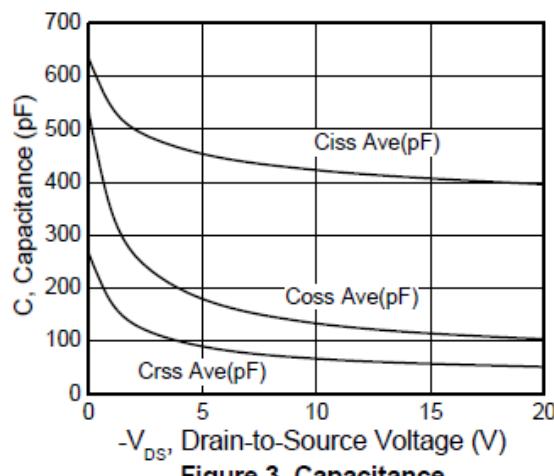


Figure 3. Capacitance

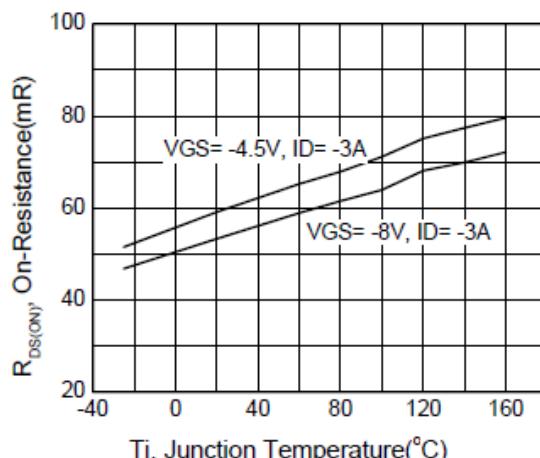


Fig 4. On-Resistance Temperature Coefficient

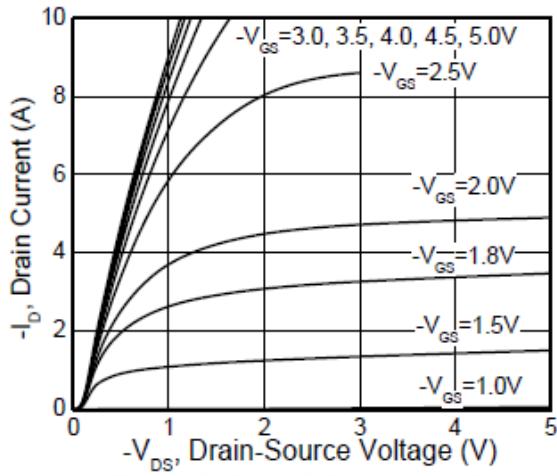


Figure 1. Output Characteristics

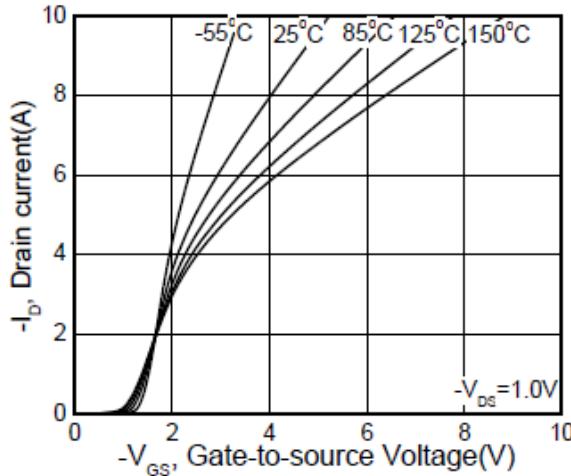


Figure 2. Transfer Characteristics

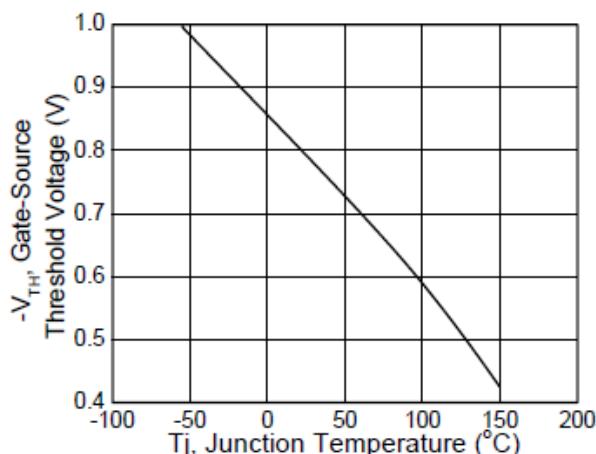


Figure 5. Gate Thersholt Vs. Temperature

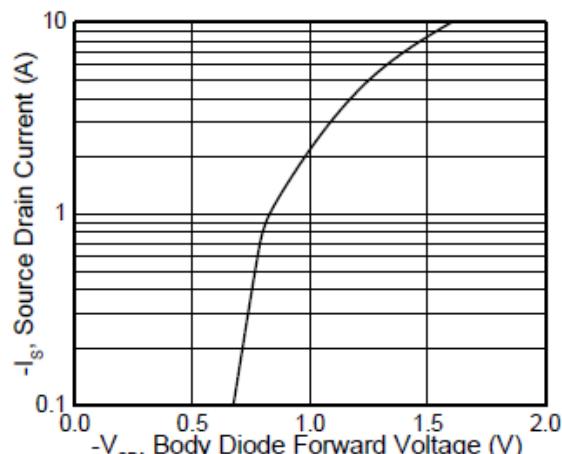


Figure 6. Body Diode Forward Voltage Vs. Source Current